

Search Notes

Application/Control No.

10/606,477

Examiner

Tuan D. Nguyen

Applicant(s)/Patent und r
R xamination

GHOMESHI ET AL.

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	421	8/2/2006	TN
	422		
	202.01		
	203.01		
381	94.5	8/3/2006	
	104		
	109		
455	567		
	550.1		
	415		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Jack Chiang	8/2/2006	TN
Duc Nguyen	8/3/2006	TN